Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/775,458	
Examiner	Art Unit
Chi O Nauron	2625

	SEARCHED			
Class	Subclass	Date	Examiner	
52	223.6	3/8/2007	CN	
52	223.8	3/8/2007	CN	
52	223.11	3/8/2007	CN	
52	335	3/8/2007	CN	
52	448	3/8/2007	CN	
52	602	3/8/2007	CN	
52	603	3/8/2007	CN	
52	608	3/8/2007	CN	
52	611	3/8/2007	CN	
	:			

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
		-		

SEARC (INCLUDING SE	H NOTES	RATEGY	_ _
		DATE	EXMR
PALM Inventor	3	3/7/2007	CN
search related art	;	3/7/2007	CN
BRS Search		3/7/2007	CN